

RED-EMC Test Report

For

JEICO

Industrial wireless remote controller

Model No.: JREMO 10K, JREMO 10KA, JREMO 10KA+, JREMO 10KB, JREMO 10KC JREMO 10KD, JREMO 10KM

Prepared For : JEICO

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Report Number : SZAWW180912004-01E

Date of Receipt : Sept. 12, 2018

Date of Test : Sept. 12~Oct. 09, 2018

Date of Report : Oct. 09, 2018



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TEST REPORT

Applicant : JEICO

Manufacturer : JEICO

Product Name : Industrial wireless remote controller

Model No. JREMO 10K, JREMO 10KA, JREMO 10KA+, JREMO 10KB, JREMO 10KC,

JREMO 10KD, JREMO 10KM

Trade Mark : **JEICO**

TX Power: 6V == 16mA

Rating(s) : RX Power: 100-230V \square 50/60Hz, 0.5A

Test Standard(s) : Draft ETSI EN 301 489-1 V2.2.0 (2017-03)

EN 55032: 2015 EN 55035: 2017

Final draft ETSI EN 301 489-3 V2.1.1 (2017-03)

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 301 489-1, EN 301 489-3 & EN 55032 and EN 55035 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test	SBOTE		Sept. 12~0	Oct. 09, 2018		
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	nbotek Anbote		Anbotek Anbo			
			Snav	y Meng		
Reviewer	Anbotek Anb	botek Anbotek	P.	0	Anbotek	Anbore
			(Supervisor	/ Snowy Meng)		
			otek S. M.	ek Anbotek		
A Ambotek Ar	norized Signer		Sally	Zhoung		
Approved & Autr	iorized Signer	Hek Anhoten	Anbe	hotek S	ote An	- Kel
			(Manager /	Sally Zhang)		



1. General Information

1.1. Client Information

Applicant	:	JEICO Anbotek Anbotek Anbotek Anbotek
Address	•	94-1, Choryang-ro, Dong-gu, Busan, Korea (48805)
Manufacturer	:	JEICO Andotek Anbotek Anbotek Anbotek Anbotek Anbotek
Address		94-1, Choryang-ro, Dong-gu, Busan, Korea (48805)
Factory	••	JEICO Anbotek Anbotek Anbotek Anbotek
Address	:	94-1, Choryang-ro, Dong-gu, Busan, Korea (48805)

1.2. Description of Device (EUT)

Product Name	:	Industrial wireless remote controller							
Model No.	:	JREMO 10K, JREMO 10KA, JREMO 10KA+, JREMO 10KB, JREMO 10KC, JREMO 10KD, JREMO 10KM (Note: All samples are the same except the name, so we prepare "JREMO 10K" for test only.)							
Trade Mark	:	JEICO PODOTE	k Anbotek Anbotek Anbotek Anbote						
Test Power Supply	:	TX: DC 6V RX: AC 110V, 50Hz / AC	X: DC 6V X: AC 110V, 50Hz / AC 230V, 50Hz						
Test Sample No.	:	S1(Normal Sample), S2(En	ngineering Sample)						
		Operation Frequency:	433.050~434.775MHz						
		Number of Channel:	70 Channels						
		Software Version:	V13 Anbotek Anbotek Anbotek Anb						
Product		Hardware Version:	V4.3						
Description	:	Product Serial Number:	1710001 Andotek Andotek						
		Modulation Type:	GFSKotek Anbotek Anbotek Anbotek						
		Antenna Type:	TX: Monopole (Film type) Antenna RX: Monopole Antenna						
		Antenna Gain(Peak):	TX & RX: 1.5 dBi						

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

N/A	k Anbote	k Aup	ore Ar	botek	Anbotek	Anboatek	A. nbotel
	1		0/0				



1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

	Pretest Mode		Description		
hbotek	Mode 1	VII.	On Mode	Anbote	An

	For Conducted Emission							
	Final Test Mode		Description					
rek.	Mode 1	ek nbotek	On Mode	anboten	Anbo			

	For Radiated Emission
Final Test Mode	Description
Mode 1	On Mode



1.5. Test Equipment List

Conducted Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
otek 1. Inbotek	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year
4.	Software Name EZ-EMC	Ferrari Tcchnology	ANB-03A	N/A	N/A	N/A

Radiated Emission Measurement

i() "	D'1.	10.5			W 111-	N 400
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
M.po	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
2. [2.]	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year
3.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year
4.ºK	Software Name EZ-EMC	Ferrari Tcchnology	ANB-03A	N/A	N/A	N/A
A5.	Preamplifier	SKET Electronic	BK1G18G30 D	KD17503	Nov. 17, 2017	1 Year
6.	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 17, 2017	1 Year
_{.e} k7.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2017	1 Year

Harmonic and Flicker Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Programmable AC Power source	IVYTECH	APS-5005A	632734	June 15, 2018	1 Year
2.	Harmonic and Flicker Analyzer	EMC-PARTNER	HRRMOINCS -1000-1P	164	Dec. 16, 2017	1 Year
3.	Harmonics-1000	N/A	Ed.3.0+4.0	N.A	N/A	N/A

Electrostatic Discharge Measurement

6	Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
	1. Arr	ESD Simulators	3Ctest	ESD-30T	ES0131505	Nov. 17, 2017	1 Year

Electrical Fast Transient/Burst Immunity Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.1	EFT Burst Simulator	PRIMA	EFT61004B	PR10114282	Nov. 17, 2017	1 Year
1.2	EFT-Clamp	PRIMA	EFT-Clamp	otek / Anbox	Nov. 17, 2017	1 Year
2.1	EFT Burst Simulator	TESEQ	NSG 3060	1480	Nov. 17, 2017	1 Year
2.2	CDN	TESEQ	CDN 3061	1408	Nov. 17, 2017	1 Year



R/S Immunity Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1	Signal Generator	Agilent	N5182A	MY48180656	Nov. 17, 2017	1 Year
2	Amplifier	Amplifier Research	150W1000M3	309410	N/A	N/A
3 _b o	Amplifier	Amplifier Research	60S1G3	309433	N/A	N/A
4 📈	Log-Periodic Antenna	Schwarzbeck	VULP9118E	00992	Aug. 17, 2018	3 Year
5	Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 18, 2017	3 Year
6	Power Sensor	Agilent	E9301A	MY41498906	N/A	N/A
nb7	Power Sensor	Agilent	E9301A	MY41498088	N/A	N/A
800	Power Meter	Agilent	E4419B	GB40202909	N/A	N/A
9	Field Probe	ETS-Lindgren	HI-6006	00212747	Apr. 20, 2017	3 Year
10	software	EMtrace	EM 3	N/A	N/A	N/A

Surge Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.1	6kV Surge Generator	TESEQ	NSG 3060	1480	Nov. 17, 2017	1 Year
1.2	CDN	TESEQ	CDN 3061	1408	Nov. 17, 2017	1 Year
2.1	6kV Surge Generator	EMPEK	LSG-5060G	06010017N	Nov. 17, 2017	1 Year
2.2	CDN	EMPEK	CDN-5110G	061100005N	Nov. 17, 2017	1 Year

Injected Currents Susceptibility Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Anbo L _A nbr	C/S Conducted Immunity Test System	FRANKONIA	CIT-10	126A1196/2012	Nov. 17, 2017	1 Year
2.	CDN AND	FRANKONIA	CDN - M2+ M3	A2210178/2012	Nov. 17, 2017	1 Year
3.	6dB Attenuator	FRANKONIA	DAM 26W	1172202	Nov. 17, 2017	1 Year
Anb 4.	CIT-10	FRANKONIA	Version1.1.7	N/A	N.A	N/A

Voltage Dips and Interruptions Measurement

	Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
800	1.	CYCLE SAG Simulator	PRIMA	DRP61011AG	PR12046234	Nov. 17, 2017	1 Year



1.6. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102

1.7. Performance Criteria

1.7.1. For EMS Test:

- \sqrt{A} : Normal performance within the specification limits;
- $\sqrt{}$ B: Temporary degradation or loss of function or performance which is self-recoverable;
- $\sqrt{}$ C: Temporary degradation or loss of function or performance which requires operator intervention or system reset;
- $\sqrt{}$ D: Degradation or loss of function which is not recoverable due to damage of equipment (components) or software, or loss of data

Note: The manufacturer's specification may define effects on the EUT which may be considered insignificant, and therefore acceptable.

This classification may be used as a guide in formulating performance criteria, by committees responsible for generic, product and product-family standards, or as a framework for the agreement on performance criteria between the manufacturer and the purchaser, for example where no suitable generic, product or product-family standard exists.

1.7.2. For EN 301 489-3:

The performance criteria are:

- performance criteria A for immunity tests with phenomena of a continuous nature;
- performance criteria B for immunity tests with phenomena of a transient nature;
- performance criteria C for immunity tests with power interruptions exceeding a certain time.

The equipment shall meet the minimum performance criteria as specified in the following clauses.



Table	1 · P	erformance	criteria

Criteria	During test	After test					
Α	Shall operate as intended.	Shall operate as intended.					
	(see note 1).	Shall be no degradation of performance (see note 3).					
	Shall be no loss of function.	Shall be no loss of function.					
	Shall be no unintentional transmissions.	Shall be no loss of stored data or user programmable functions.					
В	May show loss of function (one or more).	Functions shall be self-recoverable.					
	May show degradation of performance	Shall operate as intended after recovering.					
	(see note 2).	Shall be no degradation of performance (see note 3).					
	Shall be no unintentional transmissions.	Shall be no loss of stored data or user programmable					
		functions.					
С	May be loss of function (one or more).	Functions shall be recoverable by the operator.					
		Shall operate as intended after recovering.					
NOTE 4		Shall be no degradation of performance (see note 3).					
		vel of degradation not below a minimum performance					
		of the apparatus as intended. In some cases the					
	specified minimum performance level may be replaced by a permissible degradation of performance.						
	f the minimum performance level or the permissible performance degradation is not specified by the						
	nanufacturer then either of these may be derived from the product description and documentation including leaflets and advertising) and what the user may reasonably expect from the apparatus if						
	used as intended.	e user may reasonably expect from the apparatus if					
1		nderstood as a degradation to a level not below a					
		anufacturer for the use of the apparatus as intended. In					
	ome cases the specified minimum performance level may be replaced by a permissible degradation						
1	of performance.						
		sible performance degradation is not specified by the					
		ed from the product description and documentation					
		e user may reasonably expect from the apparatus if					
	used as intended.	,,					
NOTE 3:	No degradation of performance after the test is	understood as no degradation below a minimum					
	performance level specified by the manufacture	er for the use of the apparatus as intended. In some					
	cases the specified minimum performance leve	I may be replaced by a permissible degradation of					
		operating data or user retrievable data is allowed.					
	If the minimum performance level or the permis	sible performance degradation is not specified by the					
	manufacturer then either of these may be derive	ed from the product description and documentation					
		e user may reasonably expect from the apparatus if					
	used as intended.						

Performance criteria for Continuous phenomena applied to Transmitters (CT)

The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or Not ACKnowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Transient phenomena applied to Transmitters (TT)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Continuous phenomena applied to Receivers (CR)

The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the



transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Transient phenomena applied to Receivers (TR)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Continuous phenomena applied to Transmitters (CT)

A communication link shall be established at the start of the test, and maintained during the test, see clauses 4.2.3 and 4.2.4.

During the test, the uplink speech output level shall be at least 35 dB less than the previously recorded reference levels, when measured through an audio band pass filter of width 200 Hz, centred on 1 kHz (audio breakthrough check).

NOTE: When there is a high level background noise present the filter bandwidth can be reduced down to a minimum of 40 Hz.

At the conclusion of the test, the EUT shall operate as intended with no loss of user control functions or stored data, and the communication link shall have been maintained. In addition to confirming the above performance during a call, the test shall also be performed in idle mode, and the transmitter shall not unintentionally operate.

Performance criteria for Transient phenomena applied to Transmitters (TT)

A communications link shall be established at the start of the test, see appropriate clauses 4.2 to 4.2.4.

At the conclusion of each exposure the EUT shall operate with no user noticeable loss of the communication link. At the conclusion of the total test comprising the series of individual exposures, the EUT shall operate as intended with no loss of user control functions or stored data, as declared by the manufacturer, and the communication link shall have been maintained. In addition to confirming the above performance during a call, the test shall also be performed in idle mode, and the transmitter shall not unintentionally operate.

Performance criteria for Continuous phenomena applied to Receivers (CR)

A communications link shall be established at the start of the test, see appropriate clauses 4.2 to 4.2.6. During the test, the RXQUAL of the downlink shall not exceed the value of three, measured during each individual exposure in the test sequence.

During the test, the downlink speech output level shall be at least 35 dB less than the previously recorded reference levels, when measured through an audio band pass filter of width 200 Hz, centred on 1 kHz (audio breakthrough check).

NOTE: When there is a high level background noise present the filter bandwidth can be reduced down to a minimum of 40 Hz. At the conclusion of the test, the EUT shall operate as intended with no loss of user control functions or stored data, and the communication link shall have been maintained.

Performance criteria for Transient phenomena applied to Receivers (TR)

A communications link shall be established at the start of the test, see appropriate clauses 4.2. to 4.2.6. At the conclusion of each exposure the EUT shall operate with no user noticeable loss of the communication link. At the conclusion of the total test comprising the series of individual exposures, the EUT shall operate as intended with no loss of user control functions or stored data, as declared by the manufacturer, and the communication link shall have been maintained.



2. Summary of Test Results

Ann tek abote	anbore A	otek	Anbotek Anbo	rek hot	ak Anbo
Aupor Air	Jotek Anboten I	EMC En	nission	Por Au	otek A
Test Items	Standard		Basic Standard	Limit	Results
Conducted Emission	ETSI EN 301 489-1 Clause 8.3 & 8.4	V2.2.0	EN 55032: 2015	Class B	PASS
Radiated Emission	ETSI EN 301 489-1 Clause 8.2	V2.2.0	EN 55032: 2015	Class B	PASS
Harmonic Current Emission	ETSI EN 301 489-1 Clause 8.5	V2.2.0	EN 61000-3-2: 2014	Class A	N/A
Voltage Fluctuations& Flicker	ETSI EN 301 489-1 Clause 8.6	V2.2.0	EN 61000-3-3: 2013	Arhotek K abotek	PASS
Anbotek Anbote	Anbore An	MC Imr	nunity works	otek Anbote	
Γest Items	Standard	Anbot	Basic Standard	Performance Criteria	Results
Electrostatic Discharge	ETSI EN 301 489-1 Clause 9.3	V2.2.0	EN 61000-4-2 :2009	Ambotek B	PASS
RF Electromagnetic Field	ETSI EN 301 489-1 Clause 9.2	V2.2.0	EN 61000-4-3: 2006 +A1: 2008+A2: 2010	K Anbotek	PASS
Fast transients,	ETSI EN 301 489-1 Clause 9.4	V2.2.0	EN 61000-4-4: 2012	otek B Anbote	PASS
Surges	ETSI EN 301 489-1 Clause 9.8	V2.2.0	EN 61000-4-5: 2014+A1: 2017	Anbo'B A	PASS
Radio frequency, common mode	ETSI EN 301 489-1 Clause 9.5	V2.2.0	EN 61000-4-6: 2014	Anbotek Anbotek	PASS
Volt. Interruptions Volt. Dips	ETSI EN 301 489-1 Clause 9.7	V2.2.0	EN 61000-4-11: 2004	B/C/C NOTE (3)	PASS
NOTE:	otek Anbotek	Vupo.	ok hotek A	inbote. Anb.	401
	test is not applicable in		- VO	Anboten A	, DV
1010 NU	for equipment intended ioncentre, the class A li		used exclusively in an y be used.	industrial envir	conment or
(3) Voltage dip: 100	0% reduction – Perform	ance Cri	teria B	Anbo	, both
Voltage dip: 10	0% reduction – Perform	nance Cr	iteria B	stek Anbor	Pr.
100	% reduction – Performan	P711	16/2	botek Anbo	K An
Voltage Interrup	tion: 0% Interruption –	Perform	ance Criteria C	Nek or	boter



3. Emission Test

3.1. Conducted Emission Test at Main Ports

3.1.1. Test Standard and Limit

Test Standard	Draft ETSI EN 301	489-1 V2.2.0	Clause 8.3 & 8	3.4	Anbotek	Aupor
Basic Standard	EN 55032: 2015	hotek	Anbore	Anshotek	Anbotek	Anbo

Limits for conducted emissions

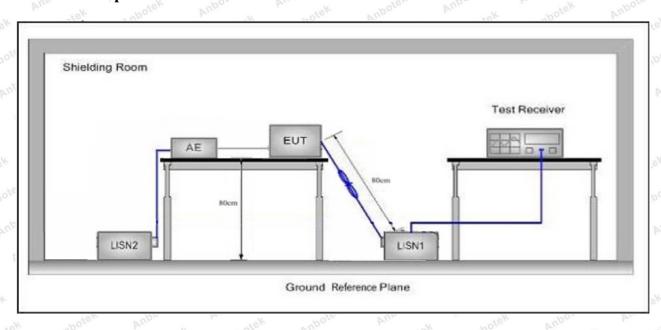
	T.	Maximum RF Line Voltage (dBuV)				
	Frequency	Quasi-peak Level	Average Level			
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *			
	500kHz~5MHz	56	46			
	5MHz~30MHz	60	50			

Limits for conducted emissions of equipment

intended to be used in telecommunication centres and industrial environment

	Eraguanav	Maximum RF Line Voltage (dBuV)				
T4 I ::4	Frequency	Quasi-peak Level	Average Level			
Test Limit	150kHz~500kHz	79 Hotek	66			
3	500kHz~30MHz	Anbou 73 Am abotek	Anboten 60 Anbo otek			

3.1.2. Test Setup





3.1.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to ETSI EN 301 489-1 V2.2.0 & EN 55032: 2015 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

For the actual test configuration, please refer to the related Item EUT Test Photos.

3.1.4. Test Data

PASS

The EUT should be compliance to the limit of Class B

Only the worst case data was showed in the report, please to see the following pages



10

11 12 4.0739

25.8500

26.1060

-2.88

13.81

2.05

20.18

20.28

20.28

17.30

34.09

22.33

46.00

60.00

50.00

-28.70

-25.91

-27.67

AVG

QP

AVG

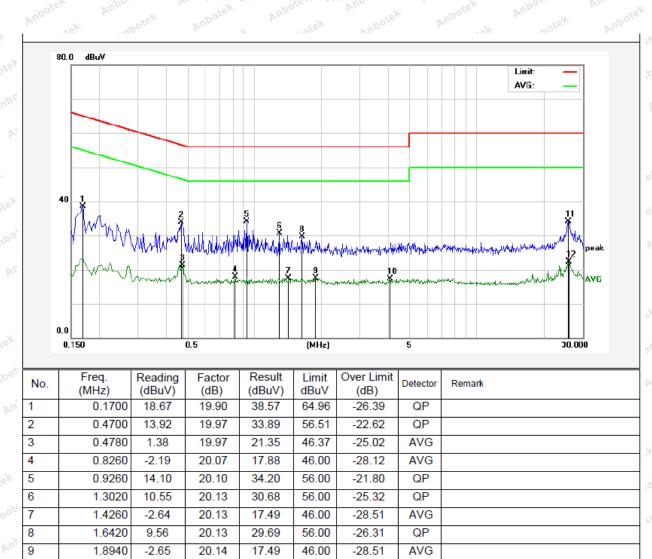
Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification:

RX: AC 110V, 50Hz
Comment: Live Line





Conducted Emission Test Data

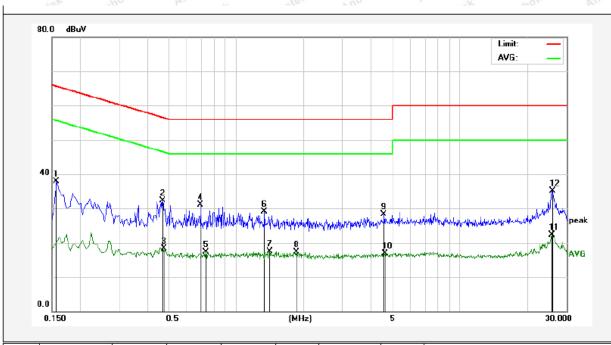
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification:

RX: AC 110V, 50Hz

Comment: Neutral Line



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit dBuV	Over Limit (dB)	Detector	Remark
1	0.1580	17.98	19.90	37.88	65.56	-27.68	QP	
2	0.4700	12.37	19.97	32.34	56.51	-24.17	QP	
3	0.4780	-1.62	19.97	18.35	46.37	-28.02	AVG	
4	0.6940	11.08	20.04	31.12	56.00	-24.88	QP	
5	0.7340	-2.82	20.05	17.23	46.00	-28.77	AVG	
6	1.3420	8.92	20.13	29.05	56.00	-26.95	QP	
7	1.4140	-2.55	20.13	17.58	46.00	-28.42	AVG	
8	1.8660	-2.90	20.14	17.24	46.00	-28.76	AVG	
9	4.5820	8.03	20.20	28.23	56.00	-27.77	QP	
10	4.6380	-3.28	20.20	16.92	46.00	-29.08	AVG	
11	25.7820	1.97	20.28	22.25	50.00	-27.75	AVG	
12	25.9180	14.83	20.28	35.11	60.00	-24.89	QP	



Conducted Emission Test Data

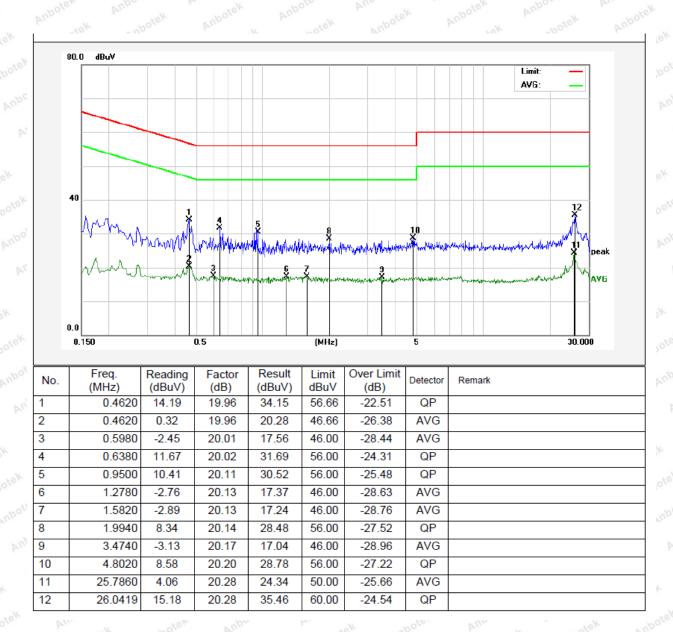
Test Site: 1# Shielded Room

Operating Condition: Mode 1

TX: DC 6V

Test Specification: RX: AC 230V, 50Hz

Comment: Live Line





Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Mode 1

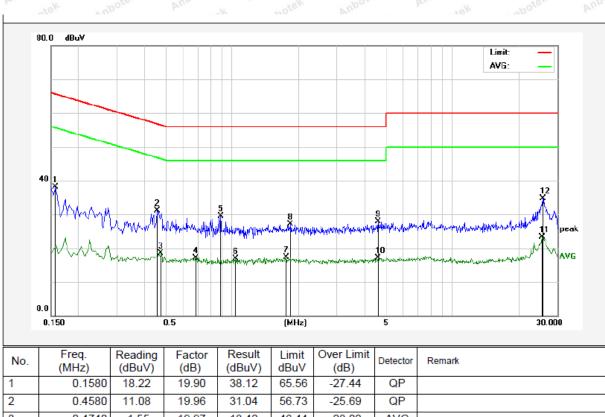
TX: DC 6V

Test Specification:

RX: BC 0V

RX: AC 230V, 50Hz

Comment: Neutral Line



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	(dBuV)	Limit dBuV	Over Limit (dB)	Detector	Remark
1	0.1580	18.22	19.90	38.12	65.56	-27.44	QP	
2	0.4580	11.08	19.96	31.04	56.73	-25.69	QP	
3	0.4740	-1.55	19.97	18.42	46.44	-28.02	AVG	
4	0.6860	-2.93	20.04	17.11	46.00	-28.89	AVG	
5	0.8860	9.38	20.09	29.47	56.00	-26.53	QP	
6	1.0420	-3.12	20.12	17.00	46.00	-29.00	AVG	
7	1.7700	-2.81	20.14	17.33	46.00	-28.67	AVG	
8	1.8420	6.98	20.14	27.12	56.00	-28.88	QP	
9	4.6060	7.61	20.20	27.81	56.00	-28.19	QP	
10	4.6060	-3.12	20.20	17.08	46.00	-28.92	AVG	
11	25.7220	3.04	20.28	23.32	50.00	-26.68	AVG	
12	25.7860	14.52	20.28	34.80	60.00	-25.20	QP	



3.2. Radiated Emission Test

3.2.1. Test Standard and Limit

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 8.2			hotek	Anbotek	Anbor	p.
Basic Standard	EN 55032: 2015	Anbotek	Anboro	Air. hotek	Anbotek	Anbo	. 1

Radiated Emission Test Limit (Below 1000MHz)

	Limit (dBμV/m) Quasi-peak Level					
Frequency (MHz)						
(MITIZ)	Class B	Class A				
30MHz~230MHz	ek abotek 40 Anbot	anbot 50 Anbo				
230MHz~1000MHz	47	57° Anbou				

Radiated Emission Test Limit (Above 1000MHz)

r		Limit (dBµV/m)						
Frequency (MHz)	Clas	s B	Class A					
(MITZ)	Peak	Average	Peak	Average				
1000 MHz -3000 MHz	70	50	76	56 Anbore				
3000 MHz -6000 MHz	Anbote 74 And	54	80	60				

Radiated Emission Test Limit for FM Receivers

E	Limit	$(dB\mu V/m)$				
Frequency (MHz)	Quasi-peak Level					
(MITIZ)	Fundamental	Harmonics				
30MHz~230MHz	60	52 nb				
230MHz~300MHz	60	tek Anbotek 52 Anbo				
300MHz~1000MHz	60	56				

Frequency Range of Radiated Measurement

Highest frequency generated or Upper frequency of measurement used in the device or on which the device operates or tunes (MHz)	Range (MHz)
Below 108	1000
108 – 500	2000
500 – 1000	5000
Above 1000	5th harmonic of the highest frequency or 6 GHz, whichever is lower



3.2.2. Test Setup

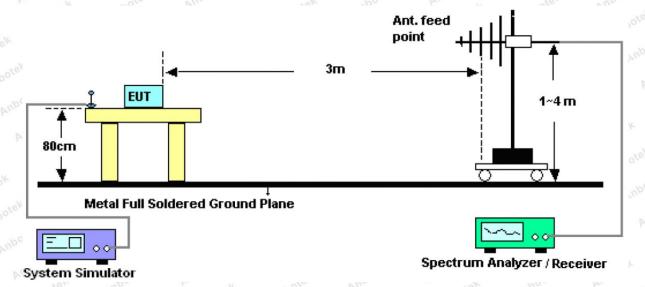


Figure 1. 30MHz to 1GHz

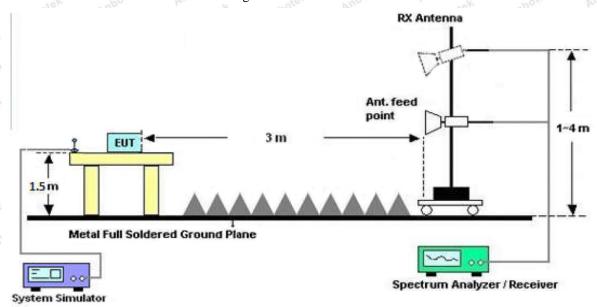


Figure 2. Above 1 GHz

3.2.3. Test Procedure

- 1) The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- 2) The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- 3) The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4) The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- 5) The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold



mode when the test frequency is below 1GHz.

The test receiver/spectrum was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1GHz.

6) For the actual test configuration, please refer to the related Item –EUT Test Photos.

Note:

The resolution bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.

The resolution bandwidth is 1MHz and video bandwidth of test receiver/spectrum analyzer is 3MHz for Peak/Average detection at frequency above 1GHz.

3.2.4. Test Data

PASS

The EUT should be compliance to the limit of Class B

Only the worst case data was showed in the report, please to see the following pages

RX: AC 110V, 50Hz

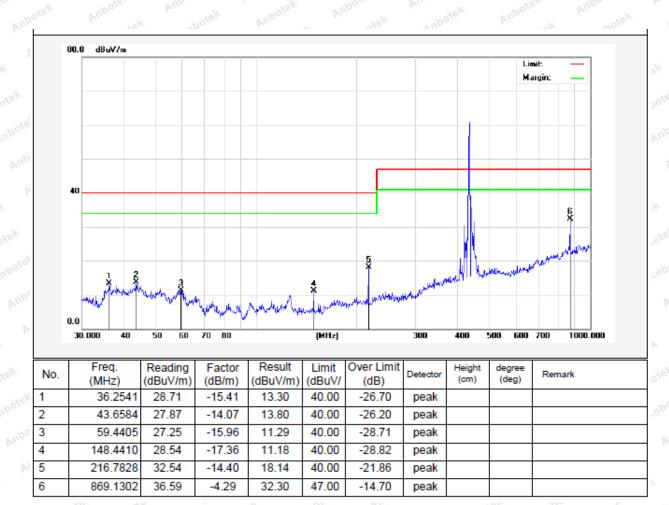


Test Results (30~1000MHz)

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 26.6°C/60%RH

Standard: EN301489_Class B_3m Power Source: TX: DC 6V

Test Mode: Mode 1 Polarization: Horizontal



RX: AC 110V, 50Hz

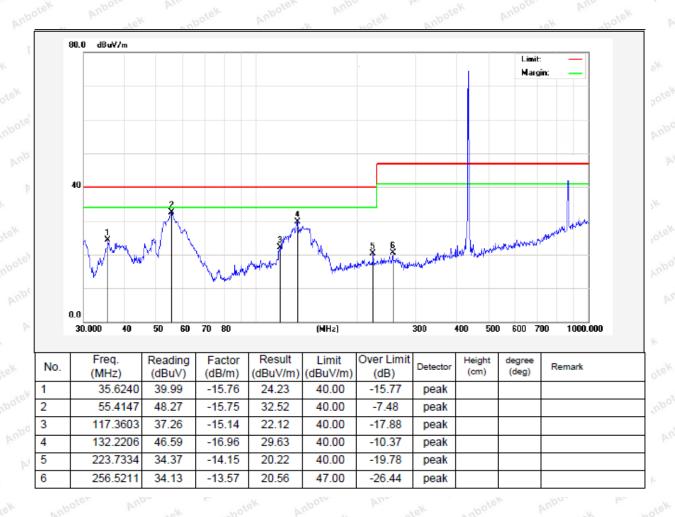


Test Results (30~1000MHz)

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 26.6°C/60%RH

Standard: EN301489_Class B_3m Power Source: TX: DC 6V

Test Mode: Mode 1 Polarization: Vertical



RX: AC 230V, 50Hz

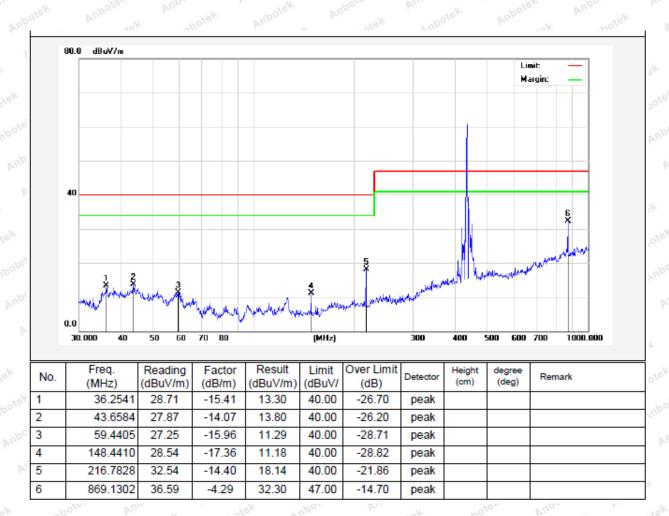


Test Results (30~1000MHz)

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 26.6°C/60%RH

Standard: EN301489_Class B_3m Power Source: TX: DC 6V

Test Mode: Mode 1 Polarization: Horizontal



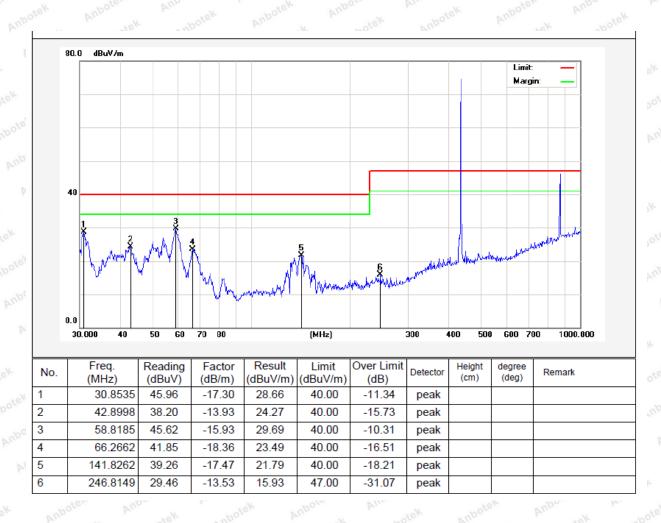


Test Results (30~1000MHz)

Job No.: SZAWW180912004-01E Temp.(℃)/Hum.(%RH): 26.6℃/60%RH

Standard: EN301489_Class B_3m Power Source: TX: DC 6V RX: AC 230V, 50Hz

Test Mode: Mode 1 Polarization: Vertical





Test Results (1GHz~6GHz)

Frequency	Read Level	Factor	Level	Limit	Over Limit	Pol.	Detector
(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	0.00	
1624.86	45.47	-2.54	42.92	70.00	-27.08	H	PEAK
1985.77	54.07	-3.35	50.73	70.00	-19.27	H An	PEAK
2198.12	53.00	-3.61	49.39	70.00	-20.61	rek H	PEAK
4020.49	52.79	-5.21	47.58	74.00	-26.42	H ^{stod}	PEAK
4674.53	52.79	-5.19	47.60	74.00	-26.40	Hek	PEAK
4839.13	50.55	-5.59	44.95	74.00	-29.05	Hote	PEAK
1624.86	39.39	-2.54	36.84	50.00	-13.16	H	AVG
1985.77	38.66	-3.35	35.31	50.00	-14.69	ek H	AVG
2198.12	38.20	-3.61	34.59	50.00	-15.41	Н	AVG
4020.49	40.84	-5.21	35.63	54.00	-18.37	H	AVG
4674.53	44.87	-5.19	39.67	54.00	-14.33	Aup H	AVG
4839.13	37.29	-5.59	31.69	54.00	-22.31	PH OF	AVG
1487.42	47.12	-2.82	44.30	70.00	-25.70	VAnb	PEAK
2125.96	54.01	-3.24	50.77	70.00	-19.23	e ^V V P	PEAK
2079.44	49.37	-3.94	45.43	70.00	-24.57	oo ^{te} V	PEAK
3981.11	46.91	-4.67	42.24	74.00	-31.76	$^{up}\mathbf{V}^{k}$	PEAK
4372.07	50.06	-4.50	45.56	74.00	-28.44	Votel	PEAK
4831.56	48.37	-5.41	42.96	74.00	-31.04	V	PEAK
1487.42	38.79	-2.82	35.98	50.00	-14.02	V	AVG
2125.96	45.37	-3.24	42.13	50.00	-7.87	V	AVG
2079.44	41.87	-3.94	37.93	50.00	-12.07	V	AVG
3981.11	44.07	-4.67	39.40	54.00	-14.60	Aupor	AVG
4372.07	42.36	-4.50	37.86	54.00	-16.14	V	AVG
4831.56	36.70	-5.41	31.29	54.00	-22.71	Valo	AVG

Remark:

1. Level =Receiver Read level + Antenna Factor

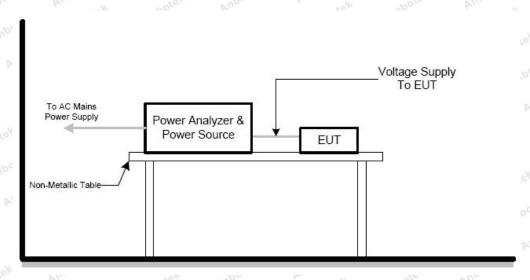


3.3. Harmonic Current Emissions

3.3.1. Test Standard and Limit

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 8.5	hotek	Anbotek	Anbo stek
Basic Standard	EN 61000-3-2: 2014	Ambotek	Anbotek	Anboatek
Test Limit	Please to refer to the clause 7 of standard EN	61000-3-2: 2	014.	Anbootek

3.3.2. Test Setup



3.3.3. Test Procedure

- 1) The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions.
- 2) The classification of EUT is according to section 5 of EN 61000-3-2: 2014. The EUT is classified as follows:

Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B: Portable tools; Arc welding equipment which is not professional equipment.

Class C: Lighting equipment.

Class D: Equipment having a specified power less than or equal to 600W of the following types: Personal computers and personal computer monitors and television.

- 3) The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.
- 4) For the actual test configuration, please refer to the related item –EUT Test Photos.

3.3.4. Test Data

The active input power of the EUT is less than 75W. Therefore, according to EN 61000-3-2, no limits are necessary.



3.4. Voltage Fluctuations and Flicker

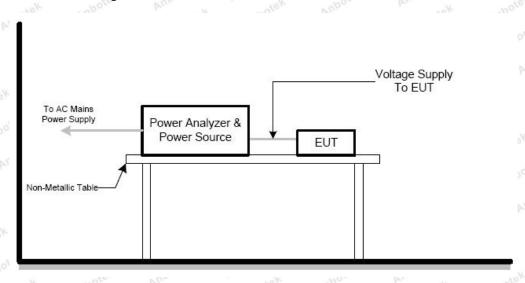
3.4.1. Test Standard and Limit

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 8.6	hotek	Anbotek	Anbo
Basic Standard	EN 61000-3-3: 2013	Am	Anbotek	Anboatek

Voltage Fluctuation and Flicker Test Limit

Test Items	Limits
Pst Pst	hotek Anbotek 1.0 botek
botes Anbotek Plt Anbotek Anbote	Anbotek 0.65 Anbotek
Anbote Anbotek dc Anbotek Anbo	3.3%
dmax Anbotek Anbotek	4.0%
Anbote An dtak Anboten Ant	Not exceed 3.3% for 500ms

3.4.2. Test Setup



3.4.3. Test Procedure

- 1) Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in Clause 5.0/6.0 of IEC555-3 and/or Clause 6.0/4.0 of IEC/EN 61000-3-3 depend on which standard adopted for compliance measurement.
- 2) All types of harmonic current and/or voltage fluctuation in this report are assessed by direct measurement using flicker-meter.
- 3) For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.4.4. Test Data

Please to see the following pages

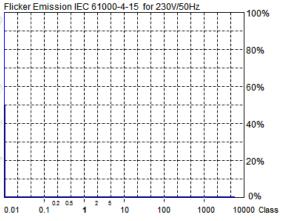


Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 24.3°C/55%RH

Standard: EN 61000-3-3 Power Source: TX: DC 6V

RX: AC 230V, 50Hz

Test Mode: Mode 1



0.00 Actual Flicker (Fli): Short-term Flicker (Pst): 0.07 Limit (Pst): 1.00 0.00 Long-term Flicker (Plt): Limit (PIt): 0.65 Maximum Relative Volt. Change (dmax): 0.00% Limit (dmax): 4.00% Relative Steady-state Voltage Change (dc): 0.00% Limit (dc): 3.00%

Tmax 3.30% (dt): 0.00ms

Limit (dt>Lim):

Flicker Emission - IEC 61000-3-3 . EN 61000-3-3

 Urms =
 229.5
 V
 P =
 1.442
 W
 Range:

 Irms =
 0.017
 A
 pf =
 0.376
 V-nom:

Test aborted, Result: PASSED

HAR-1000 EMC-Partner

500ms

0.25 A

230 V

Full Bar : Actual Values
Empty Bar : Maximum Values
Circles : Average Values

Blue: Current, Green: Voltage, Red: Failed

Urms = 229.5V Freq = 50.013 Range: 0.25 A Irms = 0.017A Ipk = 0.094A cf = 5.591 P = 1.442W S = 3.838VA pf = 0.376

Test - Time : $1 \times 10 \text{min} = 10 \text{min}$ (100 %)

LIN (Line Impedance Network): L: 0.24ohm +j0.15ohm N: 0.16ohm +j0.10ohm

Limits: Plt : 0.65 Pst : 1.00

dmax: 4.00 % dc : 3.00 % dtLim: 3.30 % dt>Lim: 500ms

Test aborted, Result: PASSED

 dmax
 dc
 dt>Lim

 [%]
 [%]
 [ms]

 0.000
 0.000
 0.000



4. Immunity Test

General Performance Criteria

◆ Performance criteria for continuous phenomena applied to transmitters and receivers (CT/CR)

During and after the test, the apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer when the apparatus is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the test the EUT shall not unintentionally transmit or change its actual operating state and stored data.

If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.

◆ Performance criteria for transient phenomena applied to transmitters and receivers (TT/TR)

After the test, the apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer, when the apparatus is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the EMC exposure to an electromagnetic phenomenon, a degradation of performance is, however, allowed. No change of the actual mode of operation (e.g. unintended transmission) or stored data is allowed.

If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.

Performance criteria for equipment which does not provide a continuous communication link

For radio equipment which does not provide a continuous communication link, the performance criteria described in CT/CR and TT/TR are not appropriate, then the manufacturer shall declare, for inclusion in the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests.

The performance criteria specified by the manufacturer shall give the same degree of immunity protection as called for in CT/CR and TT/TR.

◆ Performance criteria for ancillary equipment tested on a stand alone basis

If ancillary equipment is intended to be tested on a stand alone basis, the performance criteria described in CT/CR and TT/TR are not appropriate, then the manufacturer shall declare, for inclusion in the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests.

The performance criteria specified by the manufacturer shall give the same degree of immunity protection as called for in CT/CR and TT/TR.

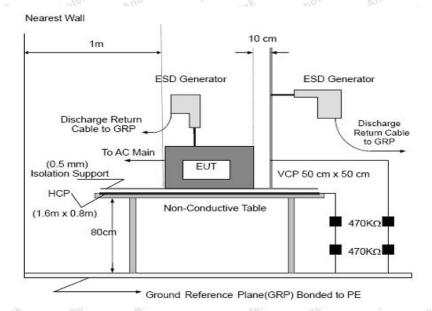


4.1. Electrostatic Discharge Test

4.1.1. Test Standard and Specification

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 9.3/EN 55035 Clause 4.2.1
Basic Standard	EN 61000-4-2: 2009
Discharge Impedance:	330 ohm / 150 pF
Performance Criterion:	CT/CR
Discharge Voltage:	Air Discharge: 2kV/4kV/8kV Contact Discharge: 2kV/4kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: min. 20 times at each test point Contact Discharge: min. 200 times in total
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

4.1.2. Test Setup



Note:

TABLE-TOP EQUIPMENT:

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940kohm total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.



FLOOR-STANDING EQUIPMENT:

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

4.1.3. Test Procedure

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

1) Contact discharge was applied to conductive surfaces and coupling planes of the EUT.

During the test, it was performed with single discharges. For the single discharge time between successive single discharges was at least 1 second.

Vertical Coupling Plane (VCP):

The coupling plane, of dimensions $0.5m \times 0.5m$, is placed parallel to, and positioned at a distance 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

2) Air discharges at insulation surfaces of the EUT.

It was at least ten single discharges with positive and negative at the same selected point.

- 3) When applying direct discharges to a portable or handheld battery-powered EUT with a display screen, it may not be possible to observe the screen for a given EUT orientation. If observation of the screen is necessary during this test, the EUT may be mounted vertically using non-metallic supports.
- 4) For the actual test configuration, please refer to the related Item –EUT Test Photos.



4.1.4. Test Data

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 24.3°C/55%RH

Standard: EN 61000-4-2 Power Source: TX: DC 6V RX: AC 230V, 50Hz

Test Mode: Mode 1

Item	Contact Discharge to coupl	Air Discharge at insulating	
Anbo	Direct Contact Discharge	Indirect Contact Discharge	surfaces
Test Voltage	Reaction of EUT / Result	Reaction of EUT / Result	Reaction of EUT / Result
+2kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS
-2kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS
+4kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS
-4kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS
+6kV	Anbotek - Anbote	And hotek - Anbotek A	n.r.r. PASS
-6kV	ek Anbotek Anbote	Anbotek - Anbotek	n.r.r. PASS
+8kV	otek Anbotek Anbot	ek abotek Anbotek	n.r.r. PASS
-8kV	sotek Anbotek Anbo	tek botek Anbotes	n.r.r. PASS

Remarks: n.r.r. = no reaction recognized

Performace Criteria A observed and No any function degraded during the tests.

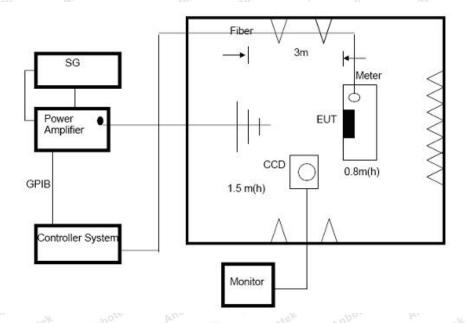


4.2. Radiated, RF Electromagnetic Fields Test

4.2.1. Test Standard and Specification

he.	of Aut to Air	
Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 9.2/EN 55035 Clause 5	
Basic Standard	EN 61000-4-3: 2006+A1: 2008+A2: 2010	
Required Performance	And otek Anbotek Anbotek Anbotek Anbotek Anbotek	
Frequency Range	80MHz to 6GHz	
Field Strength	3 V/m	
Modulation	1kHz Sine Wave, 80%, AM Modulation	
Frequency Step	1 % of preceding frequency value	
Polarity of Antenna	Horizontal and Vertical	
Test Distance	3 m nbotek Anbotek Anbotek Anbotek Anbotek Anbotek	
Antenna Height	1.5 mAnbotek Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek	
Dwell Time	at least 0.5 seconds	
41.		

4.2.2. Test Setup



4.2.3. Test Procedure

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber. The testing distance from antenna to the EUT was 3 meters.

- 1) The field strength level was 3V/m
- 2) The frequency range is swept from 80 MHz to 6000 MHz with the signal 80% amplitude modulated with a 1kHz sine wave.
- 3) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond, but shall in no case be less than 0.5s.

RX: AC 230V, 50Hz



4) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

4.2.4. Test Data

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 23.1 °C/56.7%RH

Standard: EN 61000-4-3 Power Source: TX: DC 6V

Test Mode: Mode 1

Frequency Range (MHz)	Antenna Polarity	Field Strength	Azimuth	D'11.
Anbotek Anbotek	er Anbe	3 V/m (rms)	Front	rek aboten
80~6000	Anbotek Anbotek	1000Hz, 80%	Right	□C □D
Anbotek Anbot	ek Anbotek botek Anbotek	Anbotek Anbotek Anbotek Anbote	Anbotek Anb	nbotek Anbotek
botek Anbotek				

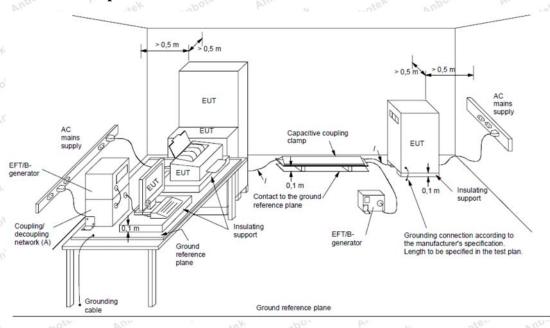


4.3. Fast Transients, Common Mode Test

4.3.1. Test Standard and Specification

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 9.4/EN 55035 Clause 4.2.4		
Basic Standard	EN 61000-4-4: 2012		
Required Performance	Band Anbotek Anbotek Anbotek Anbotek Anbotek		
Test Voltage:	Power Line: 1 kV Signal/Control Line: 0.5 KV		
Polarity:	Positive & Negative		
Impulse Frequency:	5 kHz Anbotek Anbotek Anbotek Anbotek		
Impulse Wave shape:	Tr/Th 5/50 ns		
Burst Duration:	15 ms for 5KHz Repetition Frequency 0.75 ms for 100KHz Repetition Frequency		
Burst Period:	300 ms		
Test Duration	1 min Anbotek Anbotek Anbotek Anbotek Anbotek		

4.3.2. Test Setup



Note: (A) location for supply line coupling

(B) location for signal lines coupling

For the actual test configuration, please refer to the related item - Photographs of the Test Setup

4.3.3. Test Procedure

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m*1m min. and 0.65mm thick min.

The other condition as following manner:

1) The distance between any coupling devices and the EUT should be (0.5-0/+0.1)m for table-top equipment



testing, and (1.0±0.1)m for floor standing equipment.

- 2) Both positive and negative polarity discharges were applied.
- 3) The duration time of each test sequential was 1 minute
- 4) For the actual test configuration, please refer to the related Item –EUT Test Photos.

4.3.4. Test Data

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 24.3°C/55%RH

Standard: EN 61000-4-4 Power Source: TX: DC 6V

RX: AC 230V, 50Hz

Test Mode: Mode 1

Coupling Line				Te	est lev	el (kV)					
		0.5		1		2		4		Observation	Criterion	Results
N N		+	-	+	-	+	-	+	-			
Stek Au	Γ_{e_K}	Ppo	potek P	P	P	tek	P.	hotek		Anbote Anb	potek Anb	PASS
AC Line	Notek	P	P	P	P	hotek		Anbo	ek ek	TT,TR	Anbote B A	PASS
Anbotek	L+N	P	P	Pote	P	Anbo	lek.	AT	porc	ek Anbotek	Anbotek	PASS

Note:

- 1)There was not any unintentional transmission in standby mode
- 2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.

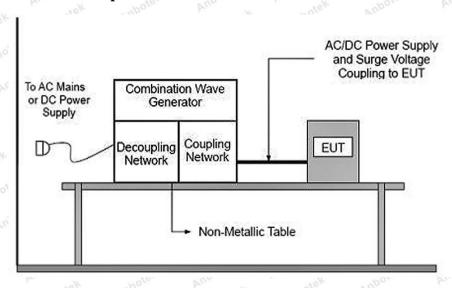


4.4. Surges Test

4.4.1. Test Standard and Specification

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 9.8/EN 55035 Clause 4.2.5
Basic Standard	EN 61000-4-5: 2014
Required Performance	Band Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Wave-Shape:	Combination Wave 1.2/50 us Open Circuit Voltage 8 /20 us Short Circuit Current
Test Voltage:	Line to Line: 1 kV; Line to ground: 2kV
Generator Source:	2 ohm between networks
Impedance:	12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	0°/90°/180°/270°
Pulse Repetition Rate:	1 time / min. (maximum)
Number of Tests:	5 positive and 5 negative at selected points

4.4.2. Test Setup



4.4.3. Test Procedure

1) For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as



for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

2) For Unshielded unsymmetrical interconnection lines:

The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

3) Unshielded symmetrical interconnections communication lines:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

4) For Shielded lines:

Direct application,

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with single or multiple shielded cables.

Rules for application of the surge to shielded lines:

- i) Shields grounded at both ends
 - > The surge injection on the shield.
- ii) Shields grounded at one end
 - > If in the installation the shield is connected only at the auxiliary equipment, test shall be done in that configuration but with the generator still connected to the EUT side. If cable lengths allow, the cables shall be on insulated supports 0.1 m above the ground plane or cable tray.

For products which do not have metallic enclosures, the surge is applied directly to the shielded cable.

- Alternative coupling method for testing single cables in a multi-shield configuration, Surges are applied in close proximity to the interconnection cable under test by a wire. The length of the cable between the port(s) under test and the device attached to the other end of the cable shall be the lesser of the maximum length permitted by the EUT's specification, or 20 m. Where the length exceeds 1 m, excess lengths of cables shall be bundled at the approximate centre of the cables with the bundles 30 cm to 40 cm in length.



4.4.4. Test Data

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 24.3 °C/55%RH

Standard: EN 61000-4-5 Power Source: TX: DC 6V

RX: AC 230V, 50Hz

Test Mode: Mode 1

Coupling Line		Test level												
		0.5 kV		1 kV		2 kV		4 kV		Observation	Criterion	Result		
			+	-	+	1	+	-	+	1				
>	nbotek	1	0°	An	ov wotel	P	Photel	6	Aupore	Non	Vu.	otek Anbo	kek An	po- otek
	AC	L-N	90°	×	Ann	P	PARP	rek	Anb	or rek	br.	TT,TR	B	PASS
y.	line	botek	180°	ro.	Ann	Potek	P	nbotek	1	Mpo	No.	Al. 11,11k	Anboten	Allis
	ek pr	nbote	270°	pote.	P	P	P	Anbot	8K	Anbo	· eK	A. botek	Anboten	Anbo

Note: 1)There was not any unintentional transmission in standby mode

2) In the table: 'P' represents 'PASS'; 'F' represents 'FAIL'.

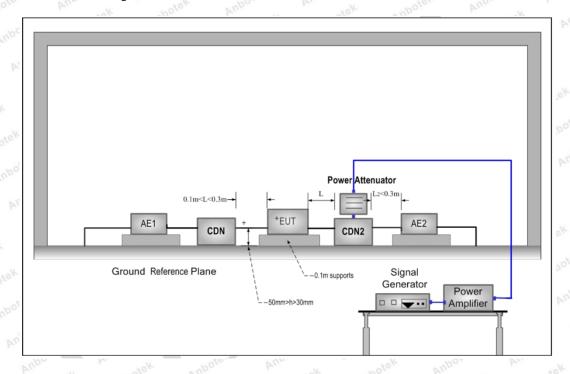


4.5. Radio Frequency, Common Mode Test

4.5.1. Test Standard and Specification

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 9.5/EN 55035:2017 Clause 5
Basic Standard	EN 61000-4-6: 2014
Required Performance	A hotek Ambolek Anbotek Anbolek Anbolek Anbolek
Frequency Range:	0.15 MHz~80 MHz/0.15MHz~10MHz, 10MHz~30MHz, 30MHz~80MHz
Field Strength:	3 Vr.m.s./3V~1Vr.m.s./3Vr.m.s.
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Dwell Time:	at least 3 seconds

4.5.2. Test Setup



4.5.3. Test Procedure

- 1) The EUT was placed on an insulating support of 0.1m height above a ground reference Plane, arranged and connected to satisfy its functional requirement. All cables exiting the EUT was supported at a height of at least 30 mm above the ground reference plane.
- 2) The coupling and decoupling devices were required, they were located between 0.1 m and 0.3 m from the EUT. This distance was to be measured horizontally from the projection of the EUT on to the ground reference plane to the coupling and decoupling device.
- 3) Each AE, used with clamp injection, shall be placed on an insulating support 0.1 m above the ground reference plane. A decoupling network shall be installed on each cable between the EUT and AE except the cable under test.



All cables connected to each AE, other than those being connected to the EUT, shall be provided with decoupling networks. The decoupling networks connected to each AE (except those on cables between the EUT and AE) shall be applied no further than 0.3 m from the AE. The cable(s) between the AE and the decoupling network (s) or in between the AE and the injection clamp shall not be bundled nor wrapped and shall be kept between 30 mm and 50 mm above the ground reference plane.

4) The frequency range was swept from 150 kHz to 230 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or to change coupling devices as necessary. Where the frequency was swept incrementally, the step size do not exceed 1% of the preceding frequency

4.5.4. Test Data

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 24.3°C/55%RH

Standard: EN 61000-4-6 Power Source: TX: DC 6V

RX: AC 230V, 50Hz

Test Mode: Mode 1

Voltage (V)	Test Frequency (MHz)	Tested Line	Injection Method.	Performance Criterion	Test Result
nbote*3	0.15~80	AC line	CDN-M2	CT/CR	PASS

Remark: For normal operating function: There was no change compared with the initial operation during and after the test.

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 24.3°C/55%RH

Standard: EN 61000-4-6 Power Source: TX: DC 6V

RX: AC 230V, 50Hz

Test Mode: Mode 1

Voltage (V)	Test Frequency (MHz)	Tested Line	Injection Method.	Performance Criterion	Test Result
Anbote 3	0.15~10	AC line	CDN-M2	CT/CR	PASS
3~1	10~30	AC line	CDN-M2	CT/CR	PASS
3 Anbot	30~80	AC line	CDN-M2	CT/CR	PASS

Remark: For normal operating function: There was no change compared with the initial operation during and after the test.

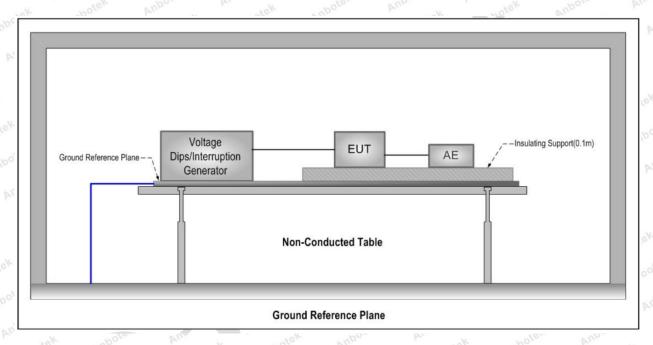


4.6. Voltage Dips and Interruptions

4.6.1. Test Standard and Specification

Test Standard	Draft ETSI EN 301 489-1 V2.2.0 Clause 9.7/EN 55035:2017 Clause 4.2.6
Basic Standard	EN 61000-4-11: 2004
Voltage Dips:	0% reduction, 0.5 Cycle 0% reduction, 1.0 Cycle 70% reduction, 25 Cycles
Voltage Interruptions:	0% reduction, 250 Cycles
Interval between Event:	Minimum 10 seconds
Phase Angle:	0°/180°
Test Cycle:	3 times

4.6.2. Test Setup



4.6.3. Test Procedure

- 1) The EUT was placed on a ground reference plane(GRP)insulated by an insulating support 0,1 m thick and the GRP was placed on a 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP.
- 2. The test was performed with the EUT connected to the test generator with the shortest power supply cable as specified by the EUT manufacturer.
- 3. The EUT was tested for each selected combination of test level and duration with a sequence of three dips/interruptions with intervals of 10 s minimum. Each representative mode of operation was tested.
- 4. For EUT with more than one power cord, each power cord was tested individually.



4.6.4. Test Data

Job No.: SZAWW180912004-01E Temp.(°C)/Hum.(%RH): 24.3°C/55%RH

Standard: EN 61000-4-11 Power Source: TX: DC 6V RX: AC 230V, 50Hz

Test Mode: Mode 1

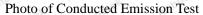
Ut:230Vac 50Hz	Dura	ntions	Event interval (sec)	Total events (time)	Performance Criterion	Result
Voltage residual (%)	(period)	(ms)	10	ek 3 nbotek	TT/TR	PASS
Anbotek O Anbo	1 nbote	20	10	otek 3 Ambot	TT/TR	PASS
Anbotel O Anbo	0.5	otek 10 Ani	10	hotek3 An	TT/TR	PASS
70	25	500	10	3	TT/TR	PASS
rek MuOyee Wu	250	5000	10	3	TT/TR	PASS
70	0.5	10	10	ak 3 nbotek	TT or CR	PASS

Ut:100Vac 50Hz	Dura	ations	Event interval (sec)	Total events (time)	Performance Criterion	Result	
Voltage residual (%)	(period)	(ms)	Anbou	3,10	TT/TR	PASS	
potek 0 pot	J'isk	20	10	3 Joseph	TT/TR	PASS	
Anbotek O Anbot	0.5	10	10	otek 3 anbote	TT/TR	PASS	
70	25	500	10	3 NO	TT/TR	PASS	
Anboten Anbo	250	5000	10	3	TT/TR	PASS	
70	0.5	10	10	3	TT or CR	PASS	

Ut:240Vac 50Hz	Dura	ations	Event interval (sec)	Total events (time)	Performance Criterion	Result
Voltage residual (%)	(period)	(ms)	10	mote3	TT/TR	PASS
ak Anb 0 Anb	Leve V	20	Anbou	3 cek	TT/TR	PASS
Porek Poore	0.5	10	10	3 botek	TT/TR	PASS
70 100 X	25	500	10	3 abote	TT/TR	PASS
Aupotek O Aupot	250	5000	10	otek 3	TT/TR	PASS
Anbote 70 Anbot	0.5	odek 10 N	10 P	3	TT or CR	PASS



APPENDIX I -- TEST SETUP PHOTOGRAPH



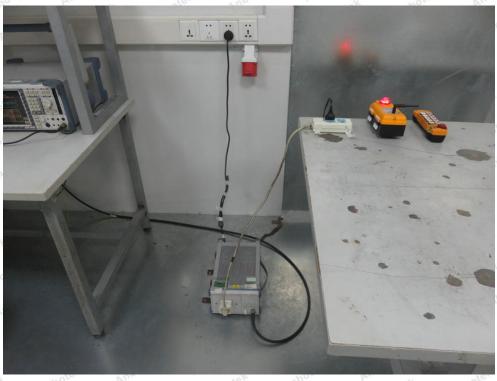


Photo of Radiation Emission Test

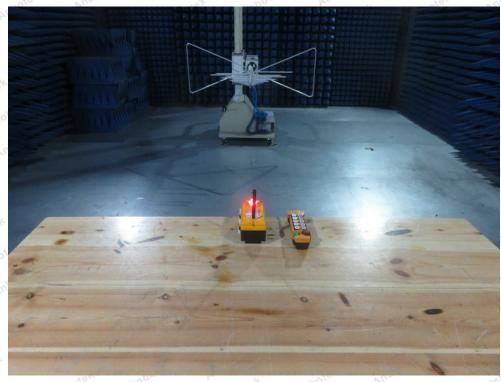
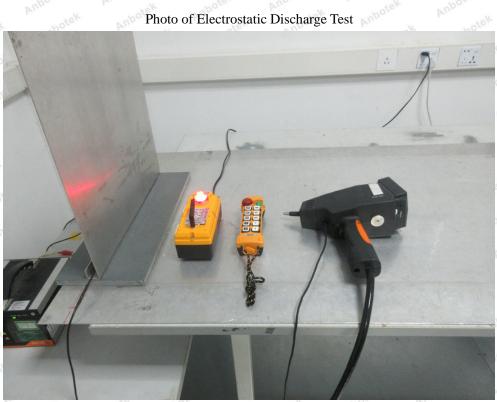




Photo of Flicker Test







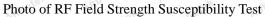
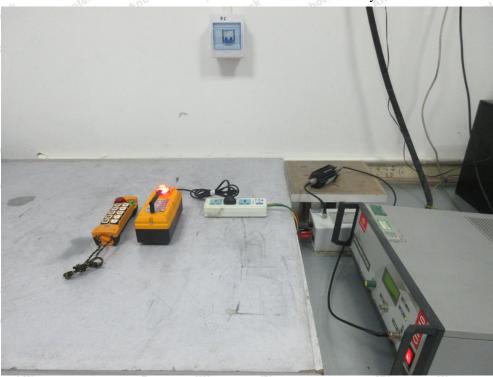




Photo of Electrical Fast Transient /Burst Immunity Test







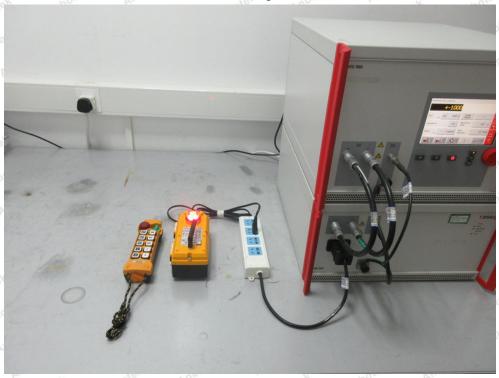


Photo of C/S Test





Photo of Dips Immunity Test





APPENDIX II -- EXTERNAL PHOTOGRAPH





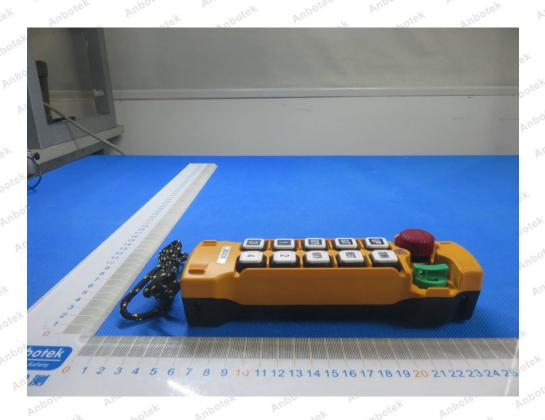




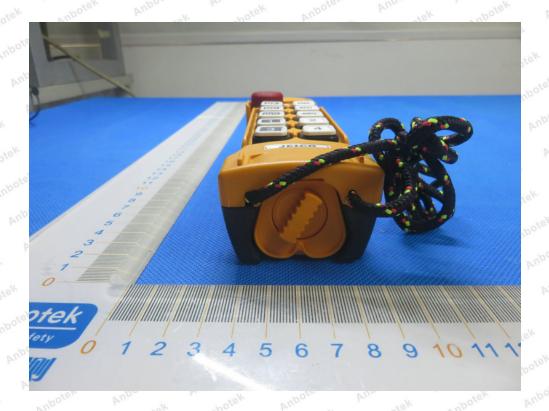
























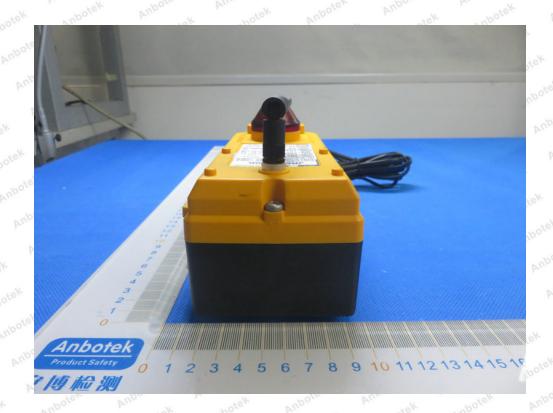












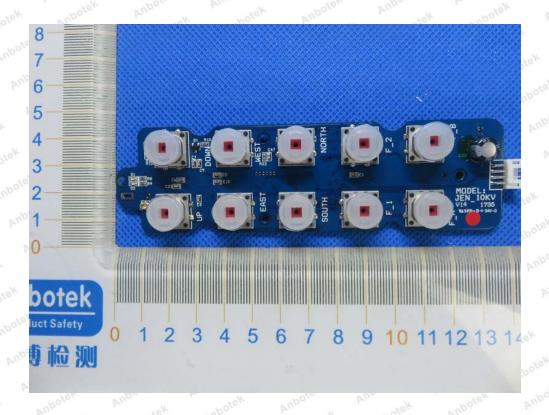


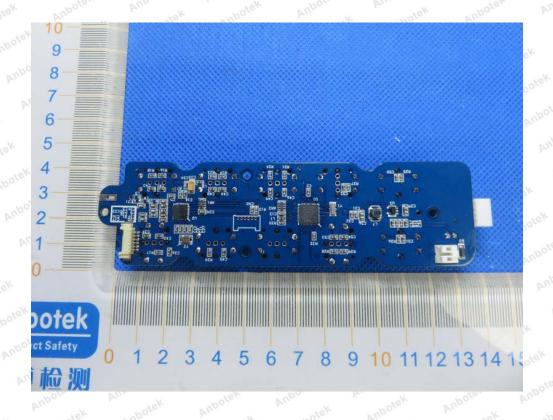
APPENDIX III -- INTERNAL PHOTOGRAPH



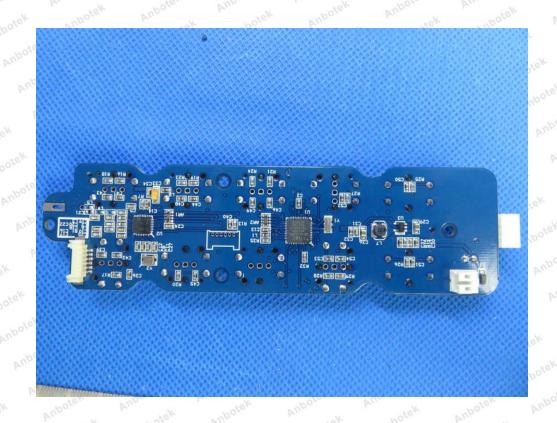


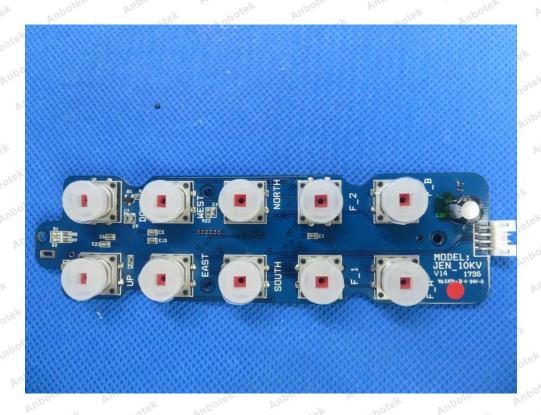




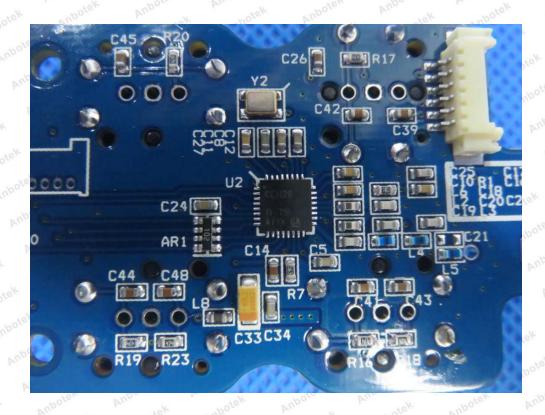


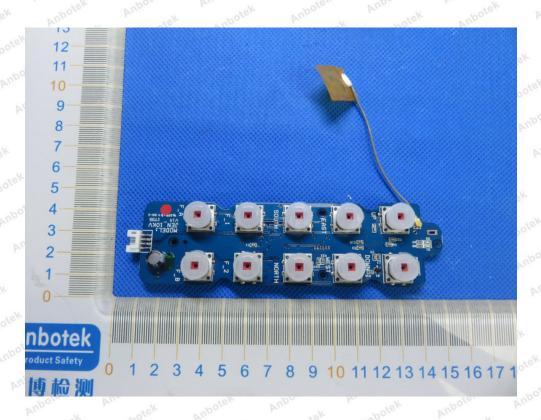




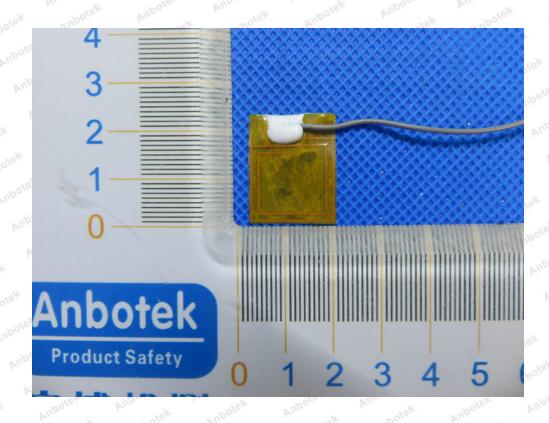


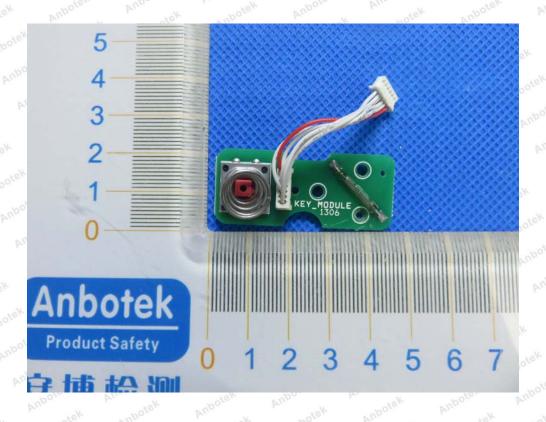




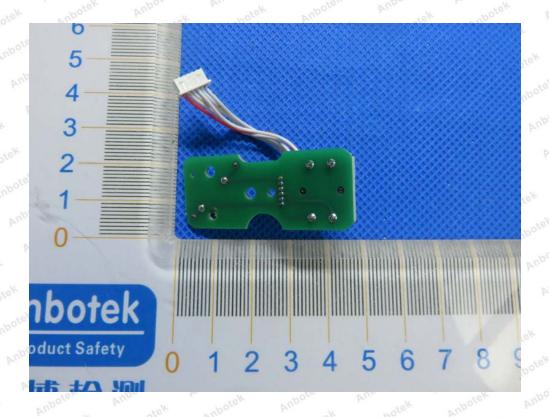








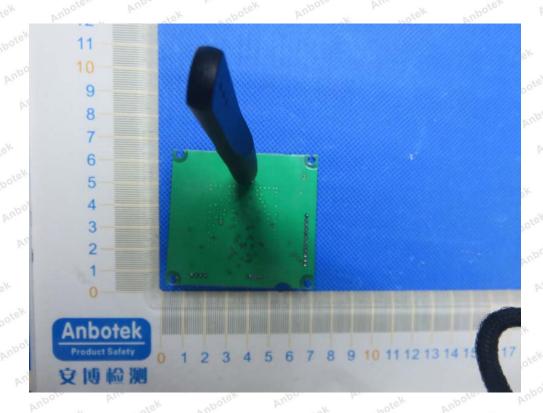




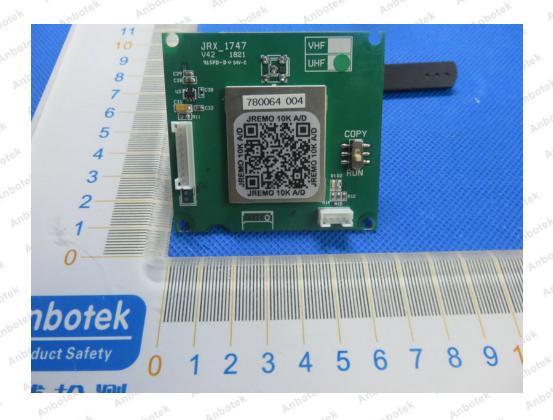


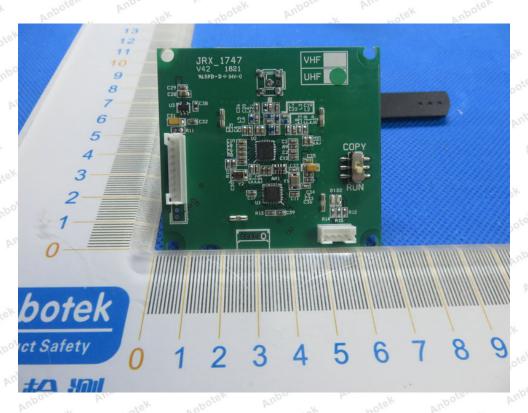




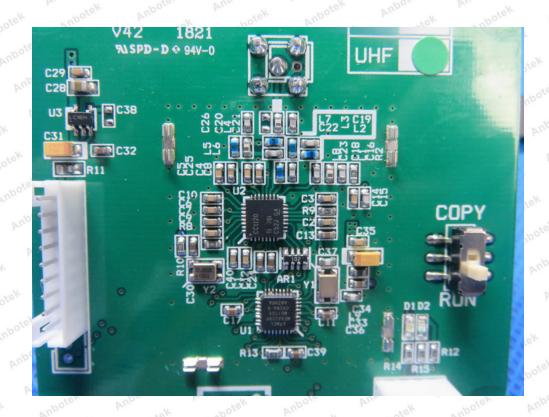


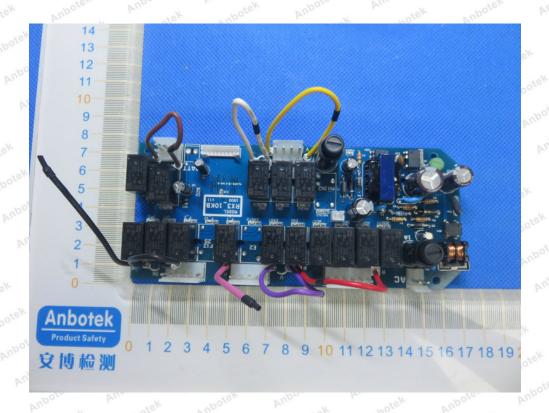




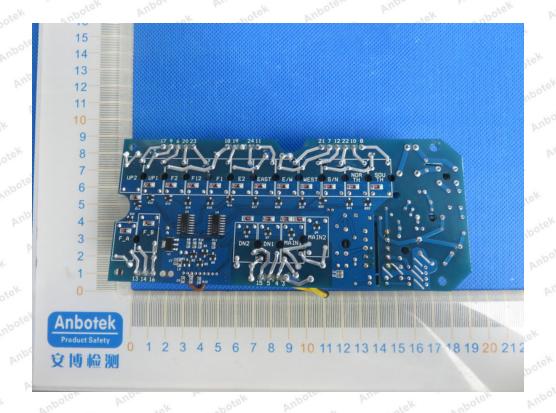


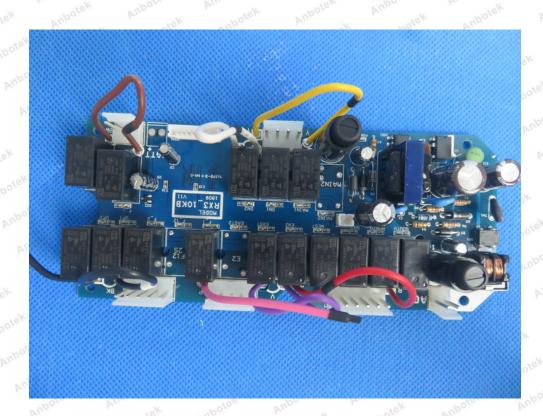




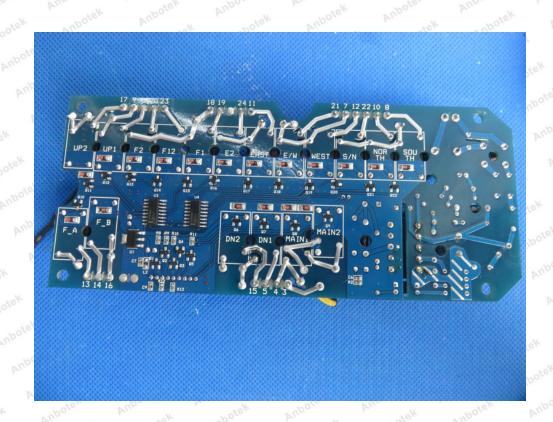












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